

**Supplementary Figure 1.**  $\text{SiO}_2$  (left column) and  $\text{Al}_2\text{O}_3$  (right column) concentration-distance profiles obtained in the crucible to glass contact to constrain possible contamination from the alumina crucible in the pure shoshonite (SHO) and rhyolite (RHY) compositions. The red line is a fit of the data using the diffusion equation for a semi-infinite medium, in the form:

$$C(x, t) = C_1 + (C_0 - C_1) * \text{erf} \left( \frac{x}{2\sqrt{Dt}} \right)$$

where  $C_0$  is the initial concentration in the melt;  $C_1$  is the concentration at the interface;  $x$  is distance in m,  $t$  is time in seconds, and  $D$  is the diffusion coefficient in  $\text{m}^2/\text{s}$ . Diffusion coefficients obtained from fitting are given in each panel. Least-squares fits were calculated using qtiPlot v. 1.0.0-rc7 software using the Levenberg-Marquadt algorithm.

